

# Metadata for Machine Analytics in High-Performance Computing

## Why collect machine health data?

- Monitor power consumption
- Improve resource management and scheduling
- Detect application signatures (power, intrusion detection)

## **Data Collection Challenges**

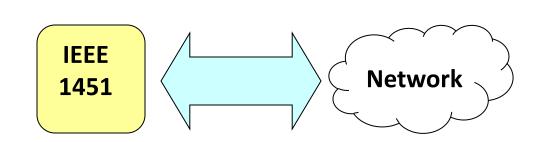
## What data to collect?

- Temperatures, voltages, current
- Fans, humidity
- What runs where when and for whom?
- Massive amount of data streaming from potentially thousands of nodes
- Because of volume, data is analyzed on the fly, only the results are persisted, precluding forensic analysis
- Sensor data variables not always accessible
- Reliance on proprietary instrumentation with no verification and validation.
- Calibration is sometimes ignored

## Metadata Challenges

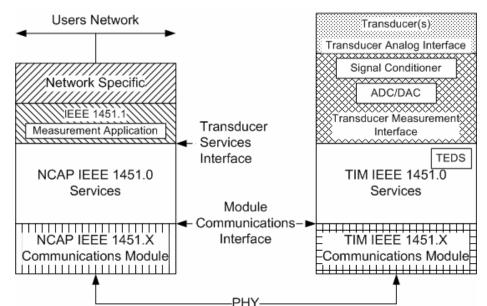
- Heterogeneous sensors and sources
- Many forms of instrumentation with output in multiple formats
- Sensor output embedded in (proprietary) system monitoring tools like CRMS.
- System sensor data is represented with numerous schemas and data models
- No single specification/package satisfies the goal of providing a metadata model suitable to analyze sensor data from all manufacturers.

## **IEEE 1451 Transducer Electronic Data Sheet**



## Data structure of a TEDS

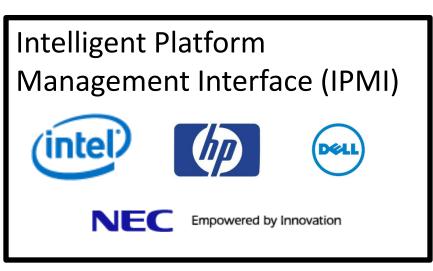
- Unsigned integer 32, 4 octets
- MetaTEDS (internal timeout value)
- Transducer Channel (sensor metadata)
- User's Transducer Name
- Frequency response
- Calibration
- Transfer function
- Command (sensor control)
- Geo-location



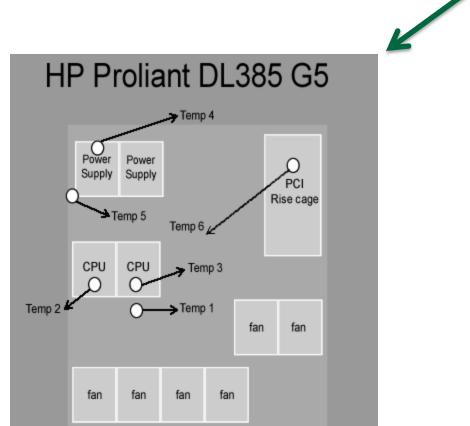
- TIM: Transducer Interface Model
- NCAP: Network Capable **Application Processor**
- PHY: Physical Connections
- ADC: Analog-to-Digital Conversion
- DAC: Digital-to-Analog Conversion

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- Adopted by over 200 equipmen manufacturers, but nor Cray
- Open source specification, requires drivers and proprietary implementations
- Sensor data is queried via ipmit -job outputs data once per minute (not customizable, calibration is tricky)







## CRAY THE SUPERCOMPUTER COMPANY

Data Volumes per d

controller node

worker node

XT5

lay	about 10 MB per node	4800 physical nodes	
	13 Voltages	13 Temperatures	
	56 voltages	55 Temperatures	

**IPMI Output** 

		acpac		
	VRM 1	0 unspecified	cr\par	ſ
	VRM 2	0 unspecified	cr\par	
	Fan 1	50.18 unspecifi   r		
	Fan 2		-	
		50.18 unspecifi   r	•	
	Fan 3	39.98 unspecifi   r	nc\par	
nt	Fan 4	39.98 unspecifi   r	nc\par	
IIC.	Fan 5	39.98 unspecifi   r	nc\par	
	Fan 6		-•	
		39.98 unspecifi   r	-	
У	Temp 1	18 degrees C	ok\par	
	Temp 2	34 degrees C	ok\par	
tool	Temp 3		ok\par	
	-			
	Temp 4	34 degrees C	ok\par	
	Temp 5	40 degrees C	ok\par	
	Temp 6	40 degrees C	ok\par	
	c0-5c0s0	L0_V_XT5_TYC0_BUS	12763	
	c0-5c0s0 c0-5c0s0	L0_V_XT5_12V_BUS L0 V XT5 DISC SW IN	12689 12763	
	c0-5c0s0	LO V XT5 DISC SW MID	12763	
	c0-5c0s0	L0_V_XT5_MEZZ_LDT	1228	
	c0-5c0s0	L0_V_XT5_MEZZ_AVDD	2468	
	c0-5c0s0	L0_V_XT5_MEZZ_CORE	1602	
	c0-5c0s0	L0_V_XT5_MEZZ_5V_BIAS	4984	
	c0-5c0s0	L0_V_XT5_NODE0_VDDA	2435	
	c0-5c0s0	L0_V_XT5_NODE1_VDDA	2473	
	c0-5c0s0	L0_V_XT5_NODE2_VDDA L0 V XT5 NODE3 VDDA	2444	
	c0-5c0s0 c0-5c0s0	LO V XT5 NODEO 12V	2426 12744	
	c0-5c0s0	LO V XT5 NODE1 12V	12672	
	c0-5c0s0	LO V XT5 NODE2 12V	12690	
	c0-5c0s0	LO V XT5 NODE3 12V	12690	
	c0-5c0s0	LO V XT5 NODEO PROCO VDDIO	1792	
	c0-5c0s0	L0 V XT5 NODE0 PROC1 VDDI0	1790	
	c0-5c0s0	L0 V XT5 NODE1 PROC0 VDDI0	1795	
	c0-5c0s0	L0 V XT5 NODE1 PROC1 VDDI0	1798	
	c0-5c0s0	L0_V_XT5_NODE2_PROC0_VDDI0	1792	
	c0-5c0s0	L0_V_XT5_NODE2_PROC1_VDDI0	1798	
	c0-5c0s0	L0_V_XT5_NODE3_PROC0_VDDT0	1798	

L0 V XT5 NODE3 PROC1

L0 V XT5 NODE0 PROC0 VTT

L0 V XT5 NODE0 PROC1 VTT

L0 V XT5 NODE1 PROCO VTT

L0 V XT5 NODE1 PROC1 VTT

L0 V XT5 NODE2 PROCO VTT

L0 V XT5 NODE2 PROC1 VTT

L0 V XT5 NODE3 PROC0 VTT

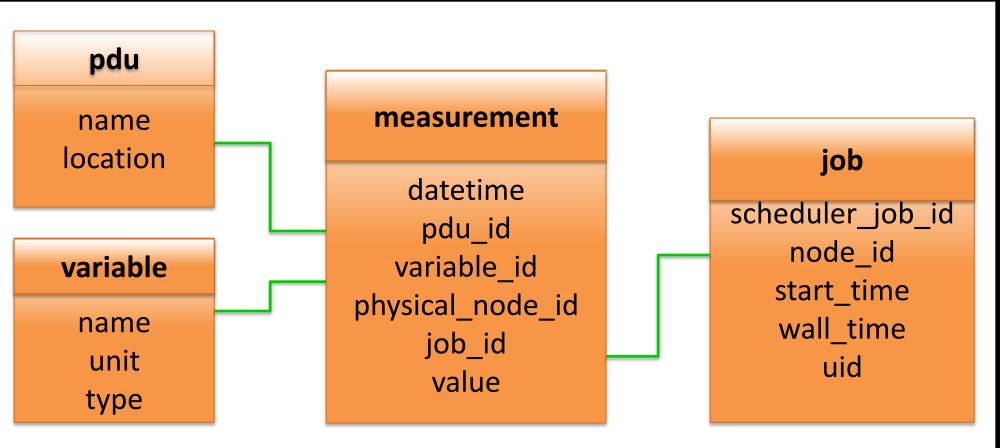
L0 V XT5 NODE3 PROC1 VTT

L0 V XT5 NC

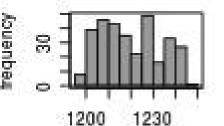




## **Data Schema**



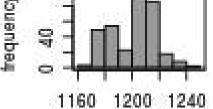
## **Distribution of voltages at core for one cabinet**

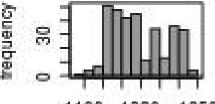


1200

1230

V node2 proc0 core\$meas





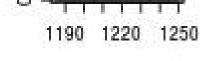
1190 1220 1250 V node1 proc1 core\$meas

V node0 proc0 core\$meas V node0 proc1 core\$meas

1180	1220
V_node1_pro	oc0_core\$meas

1170 1200 1230

V\_node3\_proc0\_core\$meas



V\_node3\_proc1\_core\$meas

## **Distribution of temperatures at core for one cabinet**

1180 1220

V node2\_proc1\_core\$meas

